

Point-Source Geometry

Photon density at I_{detector} due to Source obliquity

Assumption:

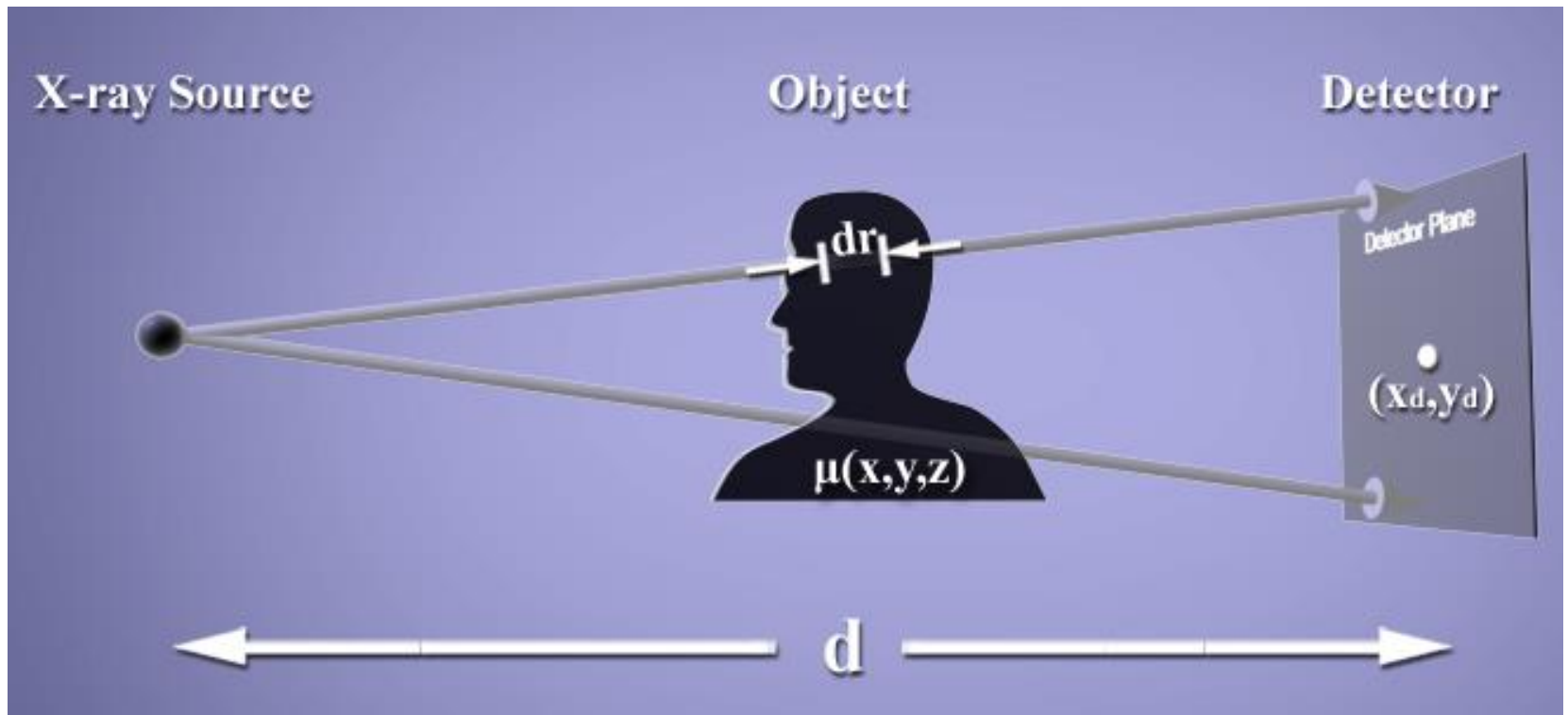
No resolution loss yet due to source.

Each ray independent of neighbors

For Parallel Rays: $I_d(x,y) = I_0 e^{-\int \mu(x,y,z) dz}$

Limitations

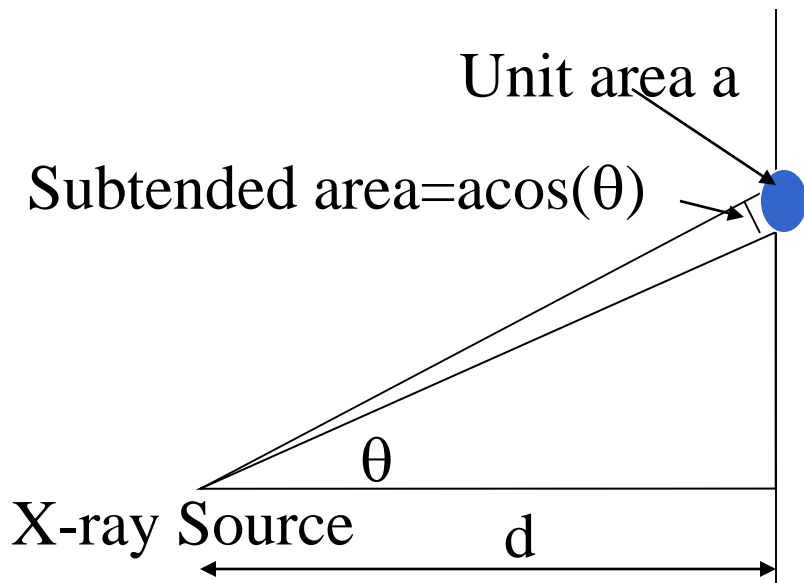
- 1) Finite Source produces rays that aren't parallel
Rays originate from a point source
- 2) Finite Detector
- 3) Distortion due to point source geometry
- 4) Resolution loss due to finite source size (not a point)



$$I_d(x_d, y_d) = I_i(x_d, y_d) \exp \left[-\int \mu_0(x, y, z) dr \right]$$

Photon density at I_{detector}

First, what if no object?



Unit area on sphere is smaller than area it subtends on detector. So for unit area on detector, area on sphere reduces by $\cos(\theta)$.

For small solid angles $\Omega \approx \text{area}/\text{distance}^2 = a (\cos \theta)/r^2$
 $\frac{\Omega}{4\pi}$ is fraction of radiation from the source covering a full sphere
 subtends 4π steradians, intercepted by Detector

$$I_d = KN \frac{\Omega}{4\pi a}$$

N photons emitted by source
 K energy per photon
 Divide by area a to normalize to detector area

$$I_d = KN \frac{\cos(\theta)}{4\pi r^2}$$

← Obliquity

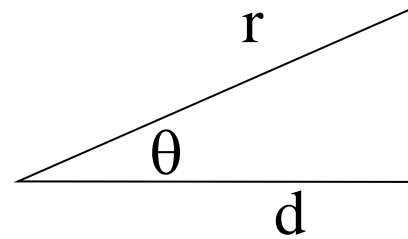
← Inverse Square Law

Normalize to $I_d(0,0) = I_0$

$$I_0 = \frac{KN}{4\pi d^2}$$

Now rewriting I_i in terms of I_0 gives,

$$I_d = I_0 \frac{d^2}{r^2} \cos(\theta)$$



$$r_d = \sqrt{x_d^2 + y_d^2}$$

$$I_d = I_0 e^{-\tau\left(\frac{x_d}{M}, \frac{y_d}{M}\right)}$$

But $\frac{d}{r} = \cos(\theta)$

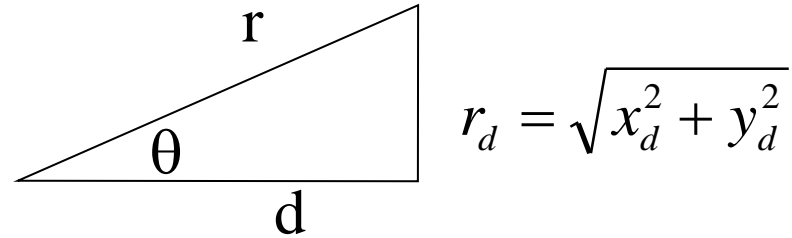
So,

$$I_d = I_0 \cos^3(\theta)$$

Source Intensity on Detector Coordinates

$$I_0 = \frac{KN}{4\pi d^2}$$

$$I_d = I_0 \cos^3 \theta$$



$$\cos(\theta) = \frac{d}{\sqrt{d^2 + r_d^2}} = \frac{1}{\sqrt{1 + \frac{r_d^2}{d^2}}}$$

$$I_d = I_0 \frac{1}{\left(1 + \frac{r_d^2}{d^2}\right)^{3/2}}$$

$\cos(\theta)$ - Obliquity

$\cos^2 \theta$ - Inverse Square
Law

Practical Example

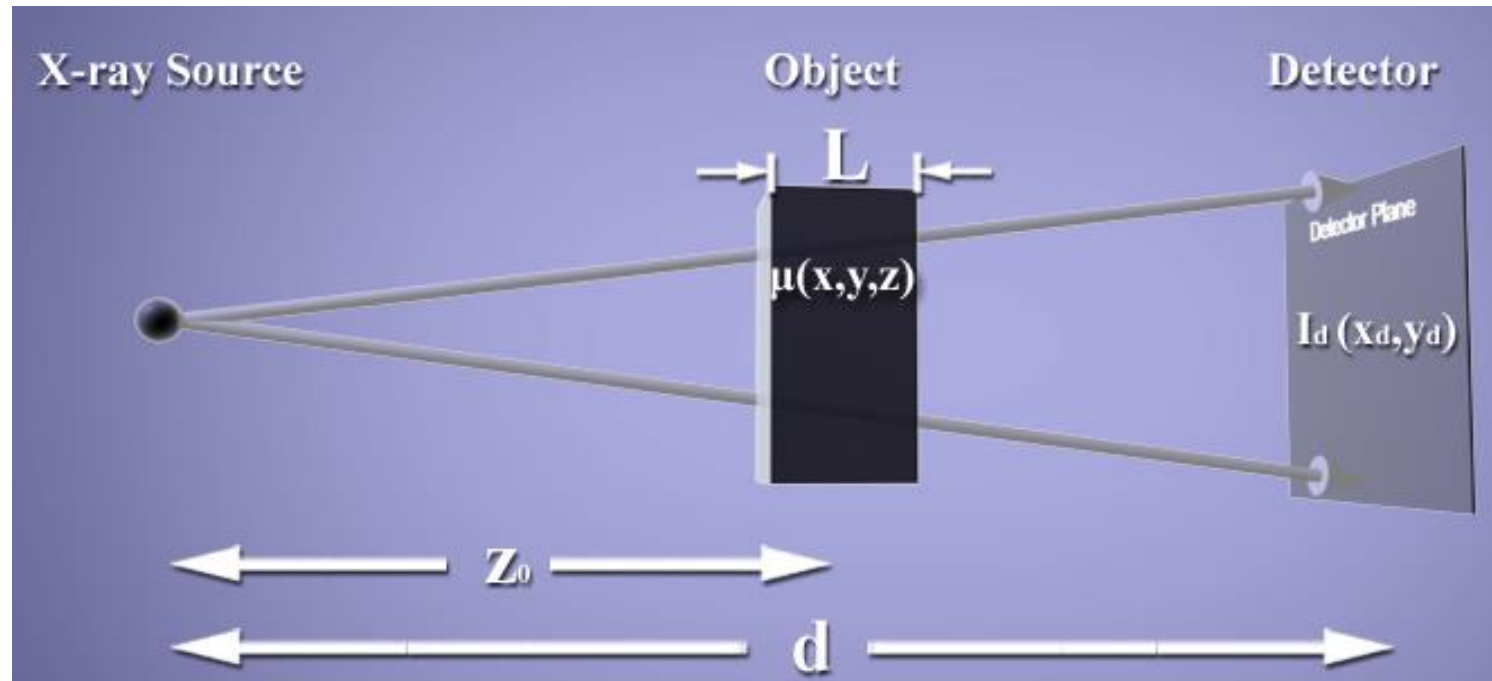
- For a 40 cm FOV with x-ray source 1 m away, how much amplitude modulation will we have due to source obliquity?

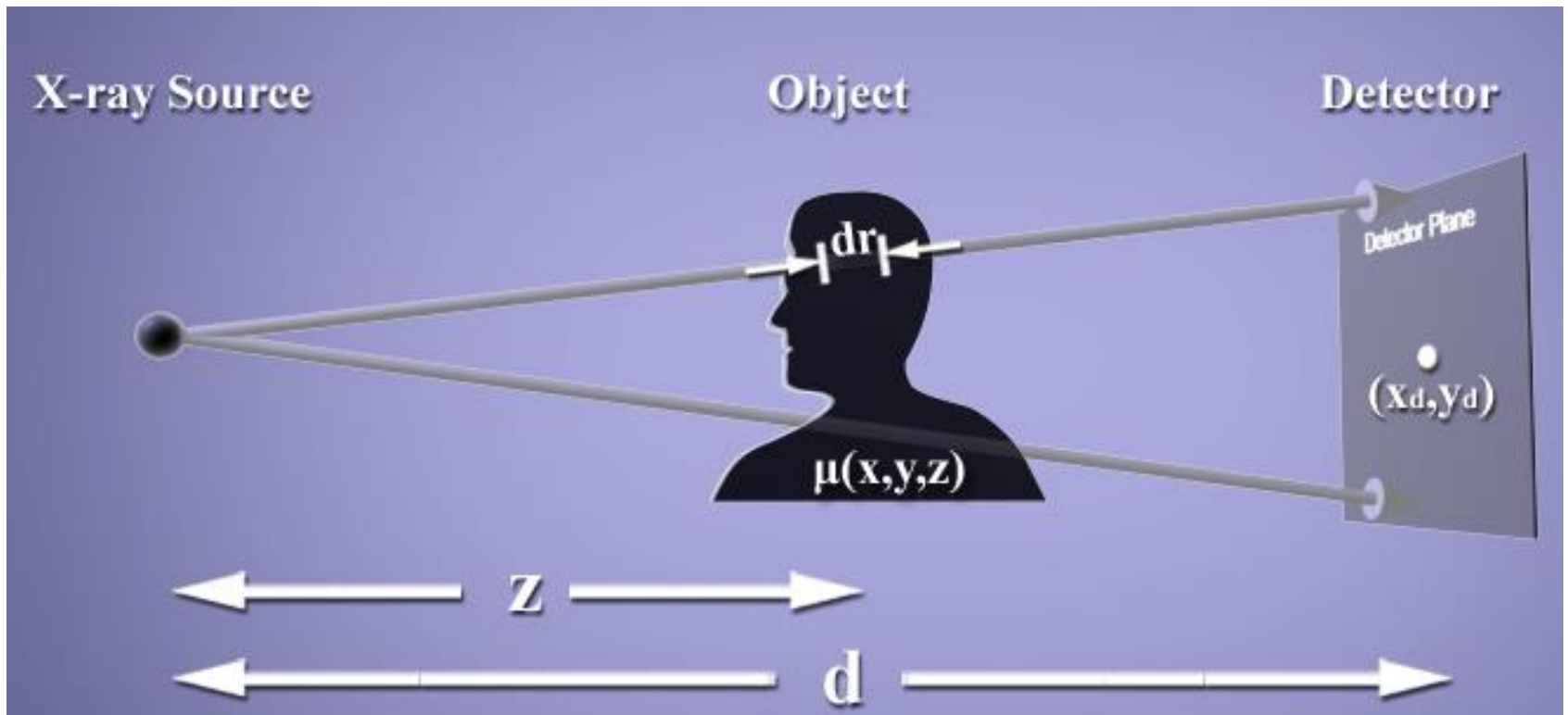
$$I_d = I_0 \frac{1}{\left(1 + \frac{r_d^2}{d^2}\right)^{3/2}}$$

Depth Dependent Magnification

Depth Dependent Magnification

Photon density change due to object obliquity





An incremental path of the x-ray, dr , can be described by its x , y , and z components.

$$dr = \sqrt{dx^2 + dy^2 + dz^2}$$

$$\frac{y_d}{y} = \frac{d}{z}$$

$$\frac{x_d}{x} = \frac{d}{z}$$

Each point in the body (x,y) can be defined in terms of the detector coordinates it will be imaged at.

$$x = \frac{x_d}{d} z \quad y = \frac{y_d}{d} z$$

Let's make intensity expression parametric in z.

$$dr = dz \sqrt{1 + (dx/dz)^2 + (dy/dz)^2} \quad dr = dz \sqrt{1 + (x_d/d)^2 + (y_d/d)^2}$$

$$r_d = \sqrt{x_d^2 + y_d^2} \quad \longrightarrow \quad dr = dz \sqrt{1 + r_d^2 / d^2}$$

Then, rewriting an earlier description in terms of the detector plane. z/d describes minification to get from detector plane to object.

$$I_d (x_d, y_d) = I_i \exp \left[- \sqrt{1 + \frac{r_d^2}{d^2}} \int \mu_o \left((x_d/d)z, (y_d/d)z, z \right) dz \right]$$

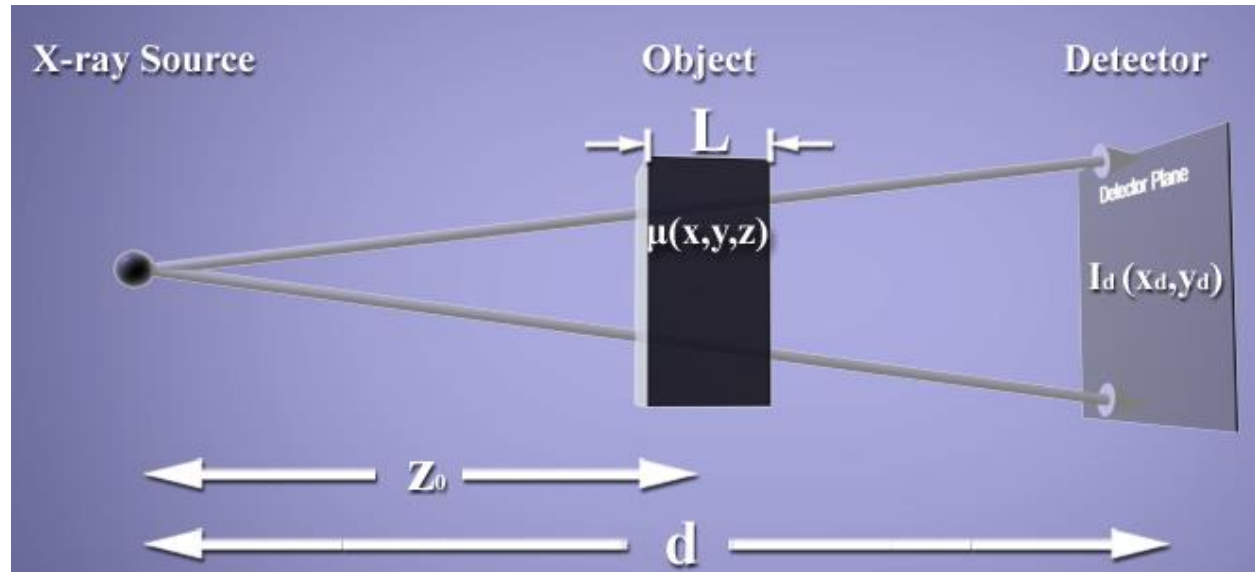
Putting it all together gives,

$$I_d = I_o / \left(\left(\frac{1 + r_d^2}{d^2} \right)^{3/2} \right) \exp \left[- \sqrt{1 + \frac{r_d^2}{d^2}} \int \mu_o \left(\left(\frac{x_d}{d} \right) z, \left(\frac{y_d}{d} \right) z, z \right) dz \right]$$

source obliquity

object obliquity

Examples 1



Object $\mu(x,y,z) = \mu_o \text{rect}((z - z_o)/L)$

Object is not a function of x or y , just z .

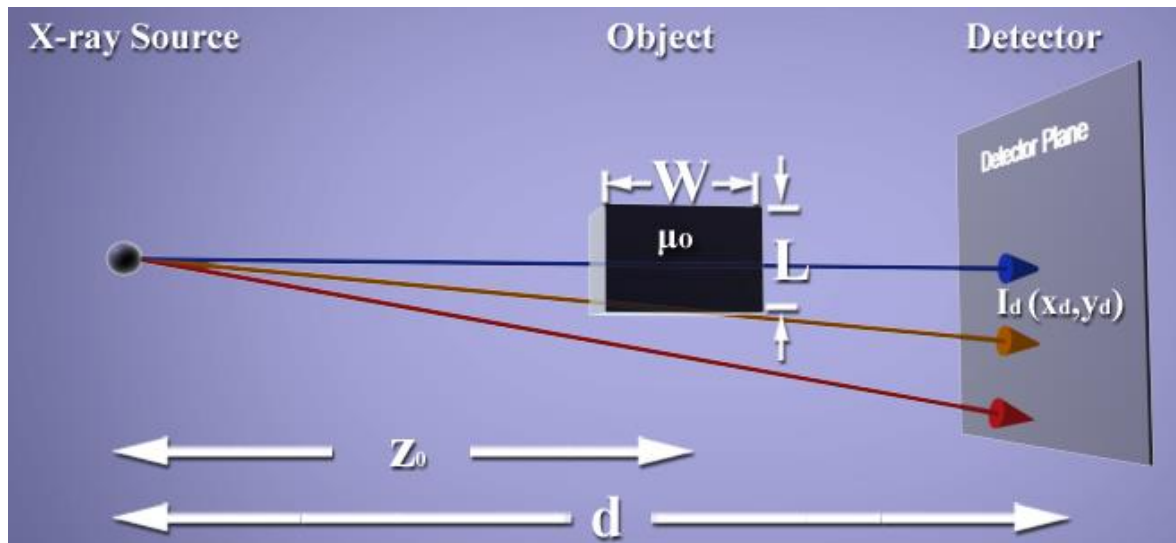
$$I_d(x_d, y_d) = I_i \exp \left[-\sqrt{1 + \frac{r_d^2}{d^2}} \mu_o L \right]$$

If we assume detector is entirely in the near axis, $r_d^2 \ll d^2$

Then, simplification results,

$$I_d = I_o e^{-\mu_o L}$$

Example 2



x out of plane
Infinite in x

For $\mu_o(x,y,z) = \mu_o \Pi(y/L) \Pi((z - z_0)/w)$

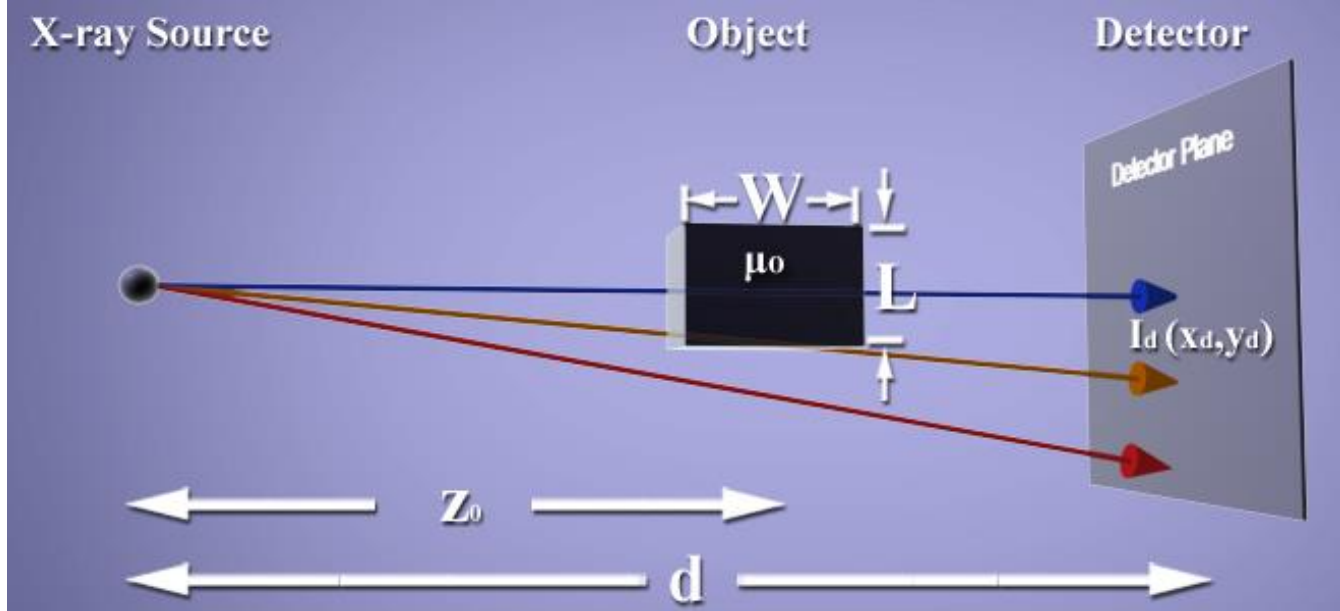
Find the intensity on the detector plane

Three cases:

1. Blue Line: X-Ray goes through entire object
2. Red Line: X-ray misses object completely
3. Orange Line: X-ray partially goes through object

$$I_d(x_d, y_d) = I_i \exp \left[- \sqrt{1 + \frac{r_d^2}{d^2}} \int \mu_o \left(\frac{x_d}{d}z, \frac{y_d}{d}z, z \right) dz \right]$$

Exam problem 2



$$I_d(x_d, y_d) = I_i \exp \left[- \sqrt{1 + \frac{r_d^2}{d^2}} \int \mu_o \left(\left(\frac{x_d}{d} \right) z, \left(\frac{y_d}{d} \right) z, z \right) dz \right]$$

For the blue line, we don't have to worry that the path length through the object will increase as r_d increases.

That is taken care of by the obliquity term $\sqrt{1 + \frac{r_d^2}{d^2}}$

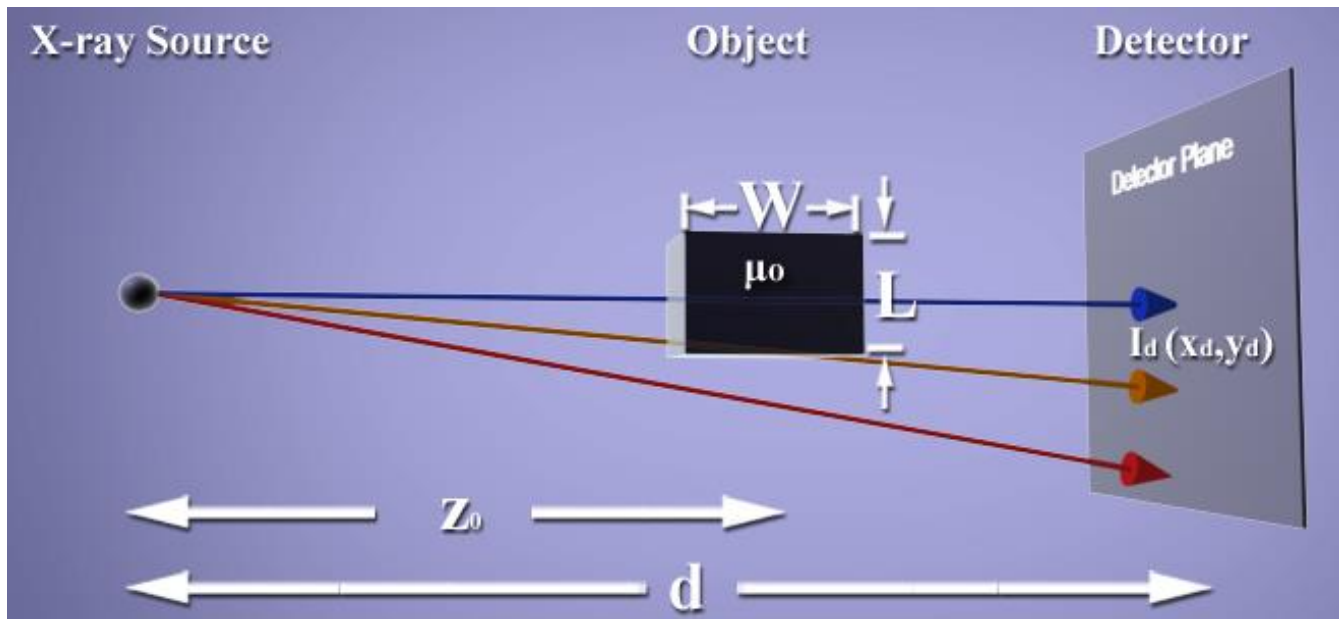
For the red path, $I_d(x_d, y_d) = I_i$

For the orange path, the obliquity term will still help describe the lengthened path.

But we need to know the limits in z to integrate

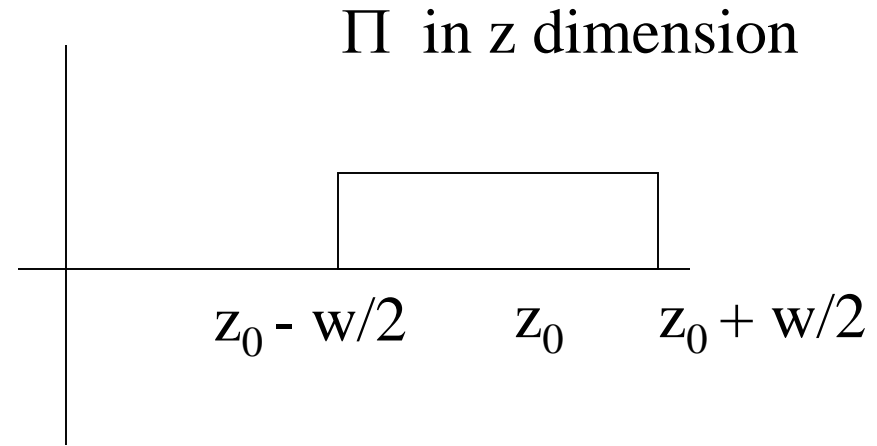
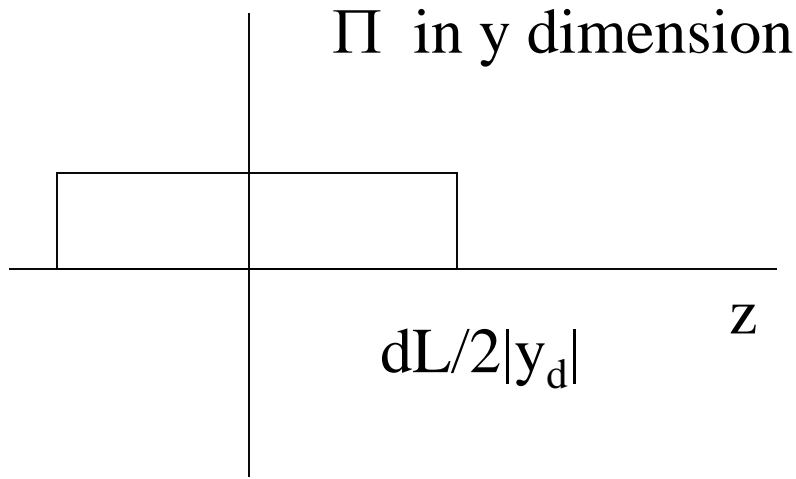
$$\mu_0(x, y, z) = \mu_0 \Pi(y/L) \Pi((z - z_0)/w)$$

Example 2



If we think of thin planes along z , each plane will form a rect in y_d of width dL/z . Instead of seeing this as a Π in y , let's mathematically consider it as a Π in z that varies in width according to the detector coordinate y_d . Then we have integration only in the variable z . The Π define limits of integration

$$I_d(x_d, y_d) = I_i \exp\left[-\sqrt{1 + \frac{r_d^2}{d^2}} \mu_0 \int_{\frac{y_d}{dL}}^{\frac{y_d - z_0}{w}} dz\right]$$



1) X-ray misses object completely

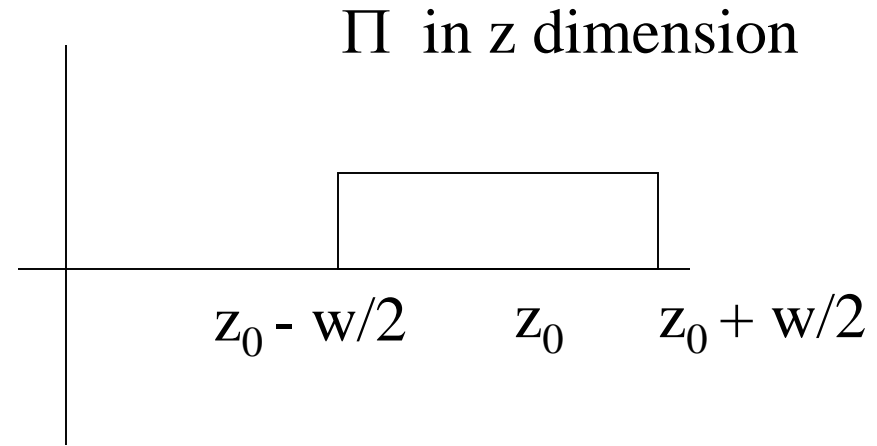
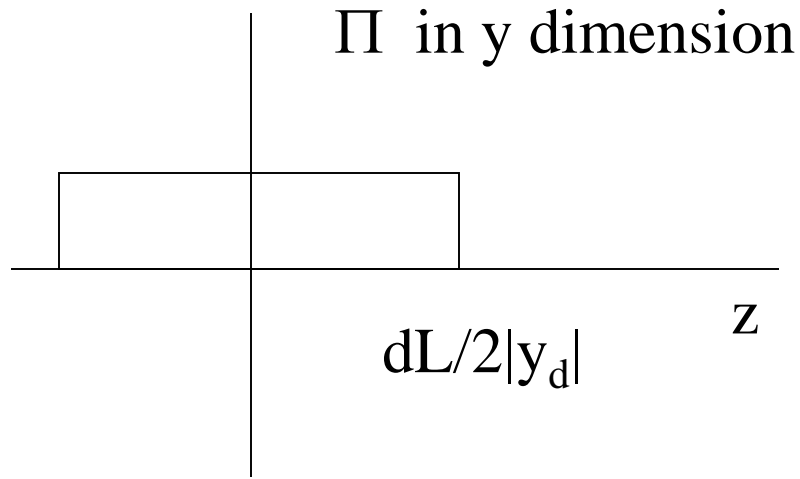
As y_d grows, first Π contracts and no overlap exists between the Π ,

functions. No overlap case when

$$dL/2y_d < z_0 - w/2$$

$$|y_d| > dL/(2 z_0 - w)$$

$$I_d = I_i$$



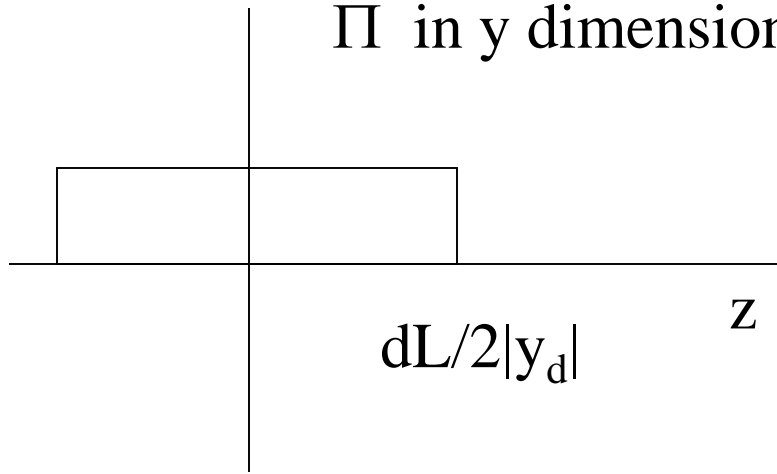
1) X-ray goes completely through object

As $y_d \rightarrow 0$, x-ray goes completely through object
 This is true for $dL/2y_d > z_0 + w/2$

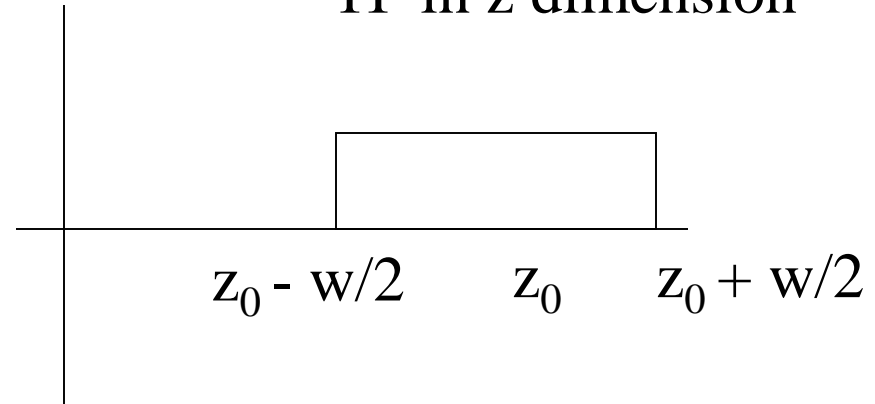
$$|y_d| < dL / (2 z_0 + w)$$

$$I_d = I_i \exp \left\{ -\mu_o \sqrt{1 + \frac{r_d^2}{d^2}} w \right\}$$

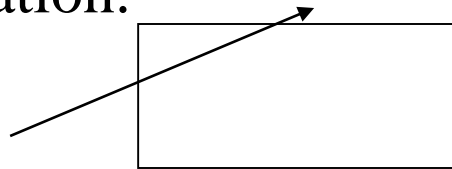
Π in y dimension



Π in z dimension



3) Partial overlap case. Picture above gives the limits of integration.



$$I_d = I_i \exp \left\{ -\mu_o \int_{\min \left\{ \begin{array}{l} z_0 - w/2 \\ dL/2|y_d| \end{array} \right\}}^{\min \left\{ \begin{array}{l} z_0 + w/2 \\ dL/2|y_d| \end{array} \right\}} - \sqrt{1 + \frac{r_d^2}{d^2}} dz \right\}$$

3) $I_d =$

$$I_i \exp \left\{ -\mu_o \sqrt{1 + \frac{r_d^2}{d^2}} \left(\frac{dL}{2|y_d|} + \frac{w}{2} - z_o \right) \right\}$$

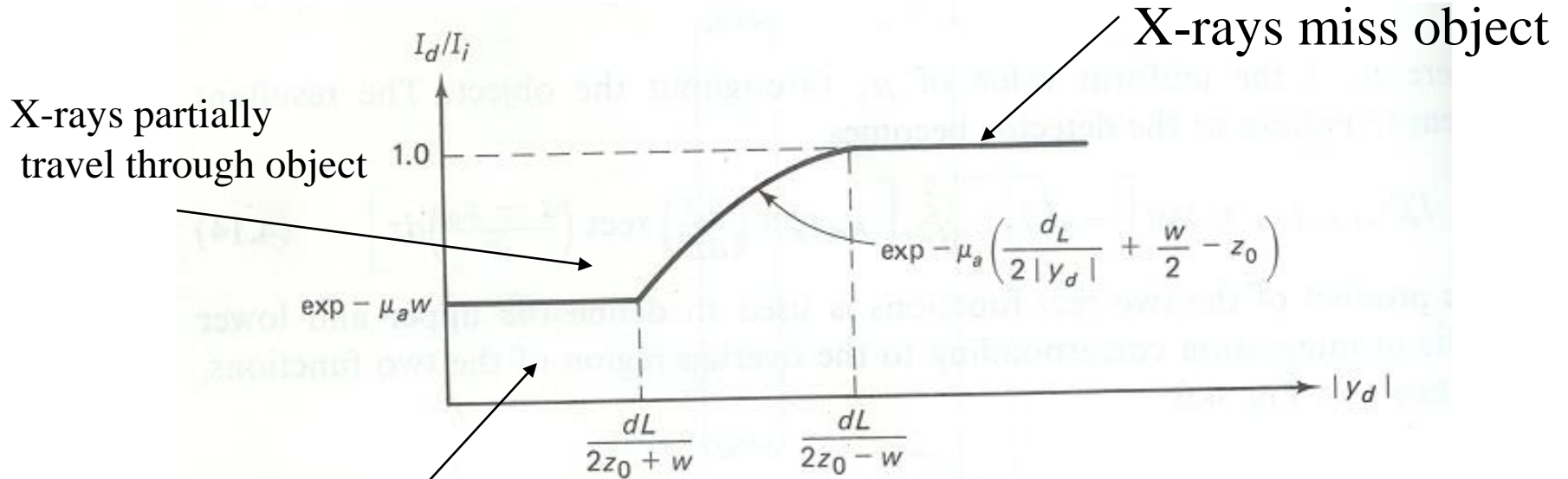


FIG. 4.7 Transmission of a rectangular object.

X-rays go entirely through object

The above diagram ignores effects of source obliquity and the factor $\sqrt{1 + \frac{r_d^2}{d^2}}$ in the exponential. How would curve look differently if we accounted for both of these?

Thin section Analysis

See object as an array of planes

$$\mu(x, y, z) = \tau(x, y) \delta(z - z_0)$$

Analysis simplifies since only one z plane

$$I_d = I_i e^{(-\sqrt{1 + \frac{r_d^2}{d^2}} \tau(\frac{x_d}{M}, \frac{y_d}{M}))}$$

where $M = d/z_0$ represents object magnification

If we ignore obliquity,

$$I_d = I_o e^{(-\tau(\frac{x_d}{M}, \frac{y_d}{M}))}$$

Or in terms of the notation for transmission, t ,

$$I_d = I_o t(\frac{x_d}{M}, \frac{y_d}{M})$$

Note: No resolution loss yet. Point remains a point.